



AO6402A

N-Channel Enhancement Mode Field Effect Transistor

General Description

The AO6402A/L uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

AO6402A and AO6402AL are electrically identical.

- -RoHS Compliant
- -AO6402AL is Halogen Free

Features

 $V_{DS}(V) = 30V$

 $I_D = 7A$

 $(V_{GS} = 10V)$

 $R_{DS(ON)}$ < 27m Ω

 $(V_{GS} = 10V)$

 $R_{DS(ON)} < 40 m\Omega$

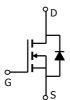
 $(V_{GS} = 4.5V)$







-55 to 150



| Absolute Maximum Ratings T _A =25°C unless otherwise noted | | | | | | | |
|--|----------------------|-------------------|---------|-------|--|--|--|
| Parameter | | Symbol | Maximum | Units | | | |
| Drain-Source Voltage | | V_{DS} | 30 | V | | | |
| Gate-Source Voltage | | V_{GS} | ±20 | V | | | |
| Continuous Drain | T _A =25°C | | 7.0 | | | | |
| Current A,F | T _A =70°C | I _D | 5.6 | A | | | |
| Pulsed Drain Current ^B | | I _{DM} | 30 | 7 | | | |
| | T _A =25°C | D | 2.0 | W | | | |
| Power Dissination | T.=70°C | —— P _D | 1 28 | vv | | | |

| Thermal Characteristics | | | | | | | | |
|---------------------------------------|--------------|---------------------|-------|------|------|--|--|--|
| Parameter | Symbol | Тур | Units | | | | | |
| Maximum Junction-to-Ambient A | t ≤ 10s | R _{0JA} | 48 | 62.5 | °C/W | | | |
| Maximum Junction-to-Ambient A | Steady-State | ⊢ K _θ JA | 74 | 110 | °C/W | | | |
| Maximum Junction-to-Lead ^C | Steady-State | $R_{\theta JL}$ | 35 | 40 | °C/W | | | |

 T_J , T_{STG}

Junction and Storage Temperature Range

°C

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Parameter Conditions | | Min | Тур | Max | Units | | | |
|-----------------------|-------------------------------------|--|-----------------------|-----|------|-----|-------|--|--|--|
| STATIC PARAMETERS | | | | | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | | 30 | | | V | | | |
| I _{DSS} | Zero Gate Voltage Drain Current | V_{DS} =30V, V_{GS} =0V | | | | 1 | μА | | | |
| | | | T _J =55°C | | | 5 | · | | | |
| I_{GSS} | Gate-Body leakage current | V_{DS} =0V, V_{GS} = ±20V | | | | 100 | nA | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS} I_D=250\mu A$ | | 1 | 1.6 | 2.5 | V | | | |
| $I_{D(ON)}$ | On state drain current | V _{GS} =10V, V _{DS} =5V | | 30 | | | Α | | | |
| R _{DS(ON)} | | V_{GS} =10V, I_D =7A | | | 22.5 | 27 | mΩ | | | |
| | Static Drain-Source On-Resistance | | T _J =125°C | | 32 | 39 | | | | |
| | | V _{GS} =4.5V, I _D =5.6A | | | 32.5 | 40 | mΩ | | | |
| g _{FS} | Forward Transconductance | V_{DS} =5V, I_{D} =7A | | | 20 | | S | | | |
| V_{SD} | Diode Forward Voltage | I _S =1A,V _{GS} =0V | | | 0.75 | 1 | V | | | |
| I_S | Maximum Body-Diode Continuous Curre | | | 2.5 | Α | | | | | |
| DYNAMIC | PARAMETERS | | | | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =15V, f=1MHz | | | 621 | 820 | pF | | | |
| C _{oss} | Output Capacitance | | | | 118 | | pF | | | |
| C _{rss} | Reverse Transfer Capacitance | | | | 85 | | pF | | | |
| R_g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | | 0.8 | 1.5 | Ω | | | |
| SWITCHI | NG PARAMETERS | | | | | | | | | |
| Q _g (10V) | Total Gate Charge | urce Charge V _{GS} =10V, V _{DS} =15V, I _D =7A | | | 11.3 | 17 | nC | | | |
| Q _g (4.5V) | Total Gate Charge | | | | 5.7 | 8 | nC | | | |
| Q_{gs} | Gate Source Charge | | | | 2.1 | | nC | | | |
| Q_{gd} | Gate Drain Charge | | | | 3 | | nC | | | |
| t _{D(on)} | Turn-On DelayTime | | | | 4.5 | 6.5 | ns | | | |
| t _r | Turn-On Rise Time | V_{GS} =10V, V_{DS} =15V, R_L =2.6 Ω , R_{GEN} =3 Ω | | | 3.1 | 5 | ns | | | |
| t _{D(off)} | Turn-Off DelayTime | | | | 15.1 | 23 | ns | | | |
| t _f | Turn-Off Fall Time | | | | 2.7 | 5 | ns | | | |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =7A, dI/dt=100A/μs | | | 15.5 | 21 | ns | | | |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =7A, dI/dt=100A/μs | | | 7.1 | 10 | nC | | | |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10$ s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

F.The current rating is based on the $t\ \leqslant$ 10s thermal resistance rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

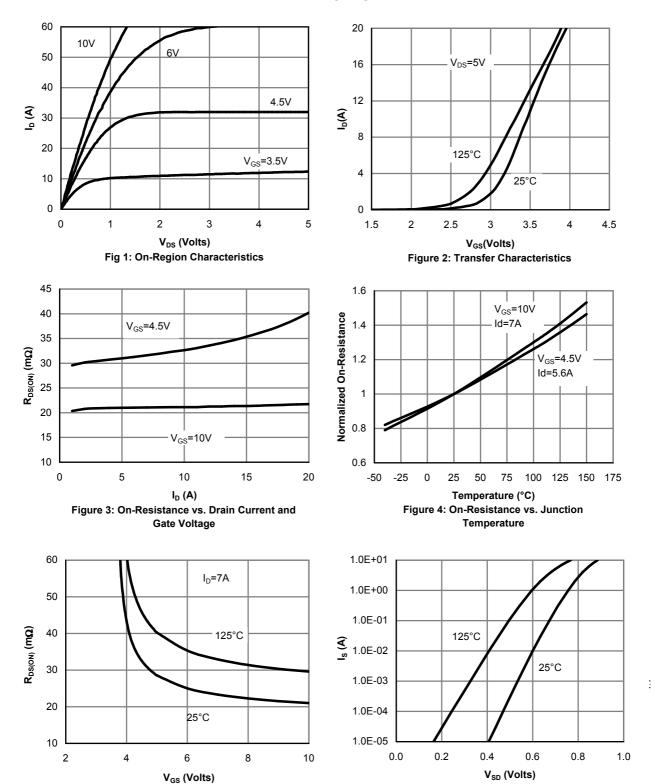


Figure 5: On-Resistance vs. Gate-Source Voltage

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

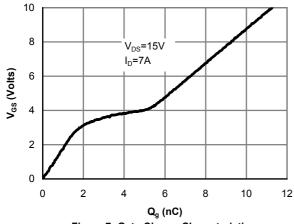


Figure 7: Gate-Charge Characteristics

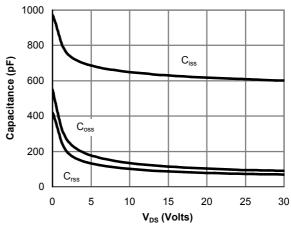


Figure 8: Capacitance Characteristics

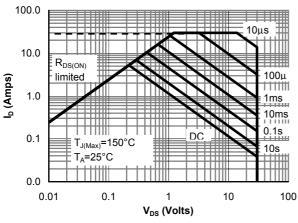


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

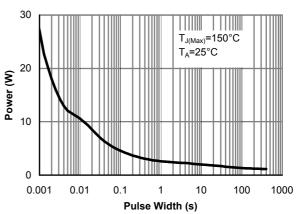


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

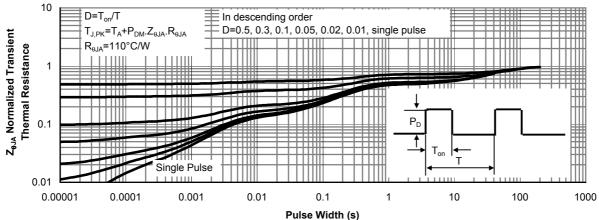
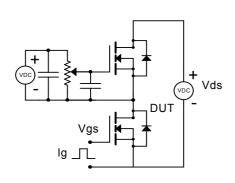
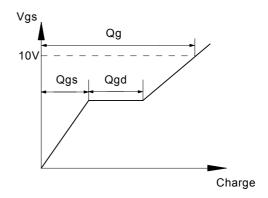


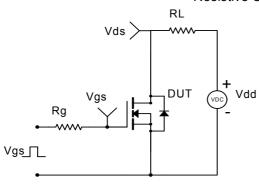
Figure 11: Normalized Maximum Transient Thermal Impedance

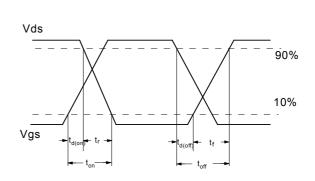
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

